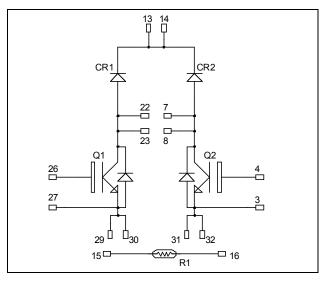
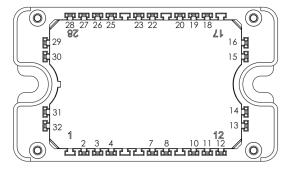
Dual Boost Chopper High speed Trench + Field Stop IGBT4 Power Module

$$V_{CES} = 650V$$

 $I_{C} = 50A$ @ $Tc = 60$ °C





All multiple inputs and outputs must be shorted together Example: 13/14; 29/30; 22/23 ...

Application

- AC and DC motor control
- Switched Mode Power Supplies
- Power Factor Correction

Features

- High speed Trench + Field Stop IGBT 4 Technology
 - Low voltage drop
 - Low leakage current
 - Low switching losses
- Kelvin emitter for easy drive
- Very low stray inductance
- Internal thermistor for temperature monitoring

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- Easy paralleling due to positive TC of VCEsat
- Each leg can be easily paralleled to achieve a single boost of twice the current capability
- RoHS compliant

All ratings @ $T_i = 25$ °C unless otherwise specified

Absolute maximum ratings (per IGBT)

| Symbol | Parameter | | Max ratings | Unit |
|-----------|--|------------------------------|-------------|------|
| V_{CES} | Collector - Emitter Voltage | | 650 | V |
| Ţ | Continuous Collector Current | $_{\rm C}$ = 25 $^{\circ}$ C | 70 | |
| I_{C} | Continuous Collector Current $\frac{T_C = 60^{\circ}}{T_C = 60^{\circ}}$ | $_{\rm C}$ = 60°C | 50 | Α |
| I_{CM} | Pulsed Collector Current T | $_{\rm C}$ = 25°C | 140 | |
| V_{GE} | Gate – Emitter Voltage | | ±20 | V |
| P_{D} | Power Dissipation | | 175 | W |

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.



| Electrical | Characteristics | (per IGBT) |
|------------|-----------------|------------|
|------------|-----------------|------------|

| Symbol | Characteristic | Test Conditions | | Min | Тур | Max | Unit |
|---------------|--------------------------------------|---|---------------------|-----|------|-----|------|
| I_{CES} | Zero Gate Voltage Collector Current | $V_{GE} = 0V, V_{CE} = 650V$ | | | | 50 | μΑ |
| V | Collector Emitter Saturation Voltage | $V_{GE} = 15V$ | $T_j = 25^{\circ}C$ | 1.4 | 1.85 | 2.3 | V |
| $V_{CE(sat)}$ | Collector Emitter Saturation Voltage | $I_C = 50A$ T_j | $T_j = 150$ °C | | 2.2 | | V |
| $V_{GE(th)}$ | Gate Threshold Voltage | $V_{GE} = V_{CE}, I_{C} = 0.8 \text{ mA}$ | | 4.2 | 5.1 | 5.6 | V |
| I_{GES} | Gate – Emitter Leakage Current | $V_{GE} = 20V, V_{CE}$ | =0V | | | 150 | nA |

Dynamic Characteristics (per IGBT)

| Symbol | Characteristic | Test Conditions | 7 | Min | Typ | Max | Unit |
|------------------|-------------------------------------|--|----------------|-----|------|------|------|
| Cies | Input Capacitance | $V_{GE} = 0V$ | | | 3100 | | |
| C_{oes} | Output Capacitance | $V_{CE} = 25V$ | | | 116 | | pF |
| C_{res} | Reverse Transfer Capacitance | f = 1MHz | | | 90 | | |
| Q_{G} | Gate charge | $V_{GE} = 15V, I_{C} = V_{CE} = 480V$ | 50A | | 315 | | nC |
| $T_{d(on)}$ | Turn-on Delay Time | Inductive Switc | hing (25°C) | | 19 | | |
| $T_{\rm r}$ | Rise Time | $\begin{aligned} V_{GE} &= \pm 15V \\ V_{Bus} &= 400V \\ I_C &= 50A \\ R_G &= 7\Omega \end{aligned}$ | | | 33 | | ns |
| $T_{d(off)}$ | Turn-off Delay Time | | | | 197 | | |
| T_{f} | Fall Time | | | | 21 | | |
| $T_{d(on)}$ | Turn-on Delay Time | Inductive Switching (150°C) $V_{GE} = \pm 15V$ | | | 19 | | |
| T_{r} | Rise Time | | | | 29 | | |
| $T_{d(off)}$ | Turn-off Delay Time | $V_{Bus} = 400V$ $I_{C} = 50A$ | | | 227 | | ns |
| T_{f} | Fall Time | $R_G = 7\Omega$ | | | 22 | | |
| Eon | Turn on Energy | $V_{GE} = \pm 15V$ $V_{Bus} = 400V$ | $T_j = 150$ °C | | 1.2 | | mJ |
| E_{off} | Turn off Energy | $I_C = 50A$ $R_G = 7\Omega$ | $T_j = 150$ °C | | 1 | | 1113 |
| I_{sc} | Short Circuit data | $V_{GE} \le 15V ; V_{Bus} = 400V t_p \le 5\mu s ; T_j = 150^{\circ}C$ | | | 350 | - | A |
| R_{thJC} | Junction to Case Thermal Resistance | | | | | 0.85 | °C/W |

Chopper Diode ratings and characteristics (per diode)

| Symbol | Characteristic | Test Conditions | | Min | Тур | Max | Unit |
|-----------------|-------------------------------------|--|--|-----|--------------|------|------|
| V_{RRM} | Peak Repetitive Reverse Voltage | | | | | 650 | V |
| I_{RM} | Reverse Leakage Current | $V_R = 650V$ | | | | 50 | μΑ |
| I_F | DC Forward Current | | $Tc = 25^{\circ}C$ | | 75 | | A |
| V_{F} | Diode Forward Voltage | $I_F = 75A$ $V_{GE} = 0V$ | $T_i = 25^{\circ}C$ $T_i = 150^{\circ}C$ | | 1.6 | 2 | V |
| t_{rr} | Reverse Recovery Time | $I_F = 75A$ $V_R = 300V$ $di/dt = 2000A/\mu s$ | $T_j = 25^{\circ}C$ $T_i = 150^{\circ}C$ | | 100 150 | | ns |
| Q _{rr} | Reverse Recovery Charge | | $T_j = 25^{\circ}C$ $T_i = 150^{\circ}C$ | | 3.6 7.6 | | μС |
| E _{rr} | Reverse Recovery Energy | | $T_j = 25^{\circ}C$ $T_j = 150^{\circ}C$ | | 0.85 1.80 | | mJ |
| R_{thJC} | Junction to Case Thermal Resistance | • | • | | | 0.98 | °C/W |



IGBT parallel diode ratings and characteristics (per diode) Symbol Characteristic Test Conditions

| Symbol | Characteristic | Test Conditions | | Min | Тур | Max | Unit |
|------------------|---|----------------------------------|----------------------------------|------|------|------|------|
| V_{RRM} | Peak Repetitive Reverse Voltage | | | | | 650 | V |
| I_{RM} | Reverse Leakage Current | $V_R = 650V$ | | | | 50 | μΑ |
| I_{F} | DC Forward Current | | $Tc = 25^{\circ}C$ | | 30 | | A |
| V_{F} | V_F Diode Forward Voltage $I_F = 30A$ | $T_i = 25^{\circ}C$ | | 1.6 | 2 | V | |
| | 3.00 | $V_{GE} = 0V$ | $T_j = 150$ °C | | 1.5 | | |
| t _{rr} | Reverse Recovery Time | | $T_j = 25$ °C | | 100 | | ns |
| ·rr | Reverse Recovery Time | 1 204 | $T_j = 150$ °C | | 150 | | 113 |
| 0 | Payarsa Racovary Charga | $I_F = 30A$ $V_R = 300V$ | $T_j = 25$ °C | | 1.5 | | μC |
| Vп | Q_{rr} Reverse Recovery Charge $V_R = 300V$ $di/dt = 1800A/\mu s$ | $T_{\rm j} = 150^{\circ}{\rm C}$ | | 3.1 | | μС | |
| E | E _{rr} Reverse Recovery Energy | $T_j = 25^{\circ}C$ | | 0.34 | | mJ | |
| Lir | | | $T_{\rm j} = 150^{\circ}{\rm C}$ | | 0.75 | | 1113 |
| R_{thJC} | Junction to Case Thermal Resistance | | | | | 2.45 | °C/W |

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

| Symbol | Characteristic | | Min | Typ | Max | Unit |
|------------------------|-----------------------------|-----------------------|-----|------|-----|------|
| R ₂₅ | Resistance @ 25°C | | | 50 | | kΩ |
| $\Delta R_{25}/R_{25}$ | | | | 5 | | % |
| $B_{25/85}$ | $T_{25} = 298.15 \text{ K}$ | | | 3952 | | K |
| $\Delta B/B$ | | T _C =100°C | | 4 | | % |

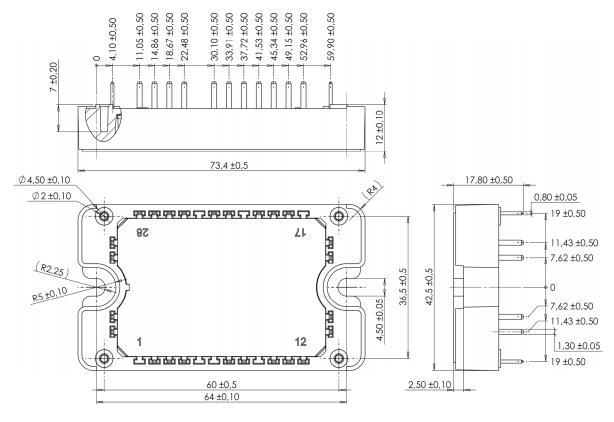
$$R_T = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$
 T: Thermistor temperature R_T: Thermistor value at T

Thermal and package characteristics

| Symbol | Characteristic | | | Min | Max | Unit |
|-------------|---|-------------|-----|-----|------------------------|------|
| V_{ISOL} | RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz | | | | | V |
| T_{J} | Operating junction temperature range | | | | 175 | |
| T_{JOP} | Recommended junction temperature under switching conditions | | | -40 | T _J max -25 | °C |
| T_{STG} | Storage Temperature Range | | | -40 | 125 | |
| $T_{\rm C}$ | Operating Case Temperature | -40 | 125 | | | |
| Torque | Mounting torque | To heatsink | M4 | 2 | 3 | N.m |
| Wt | Package Weight | | | | 110 | g |



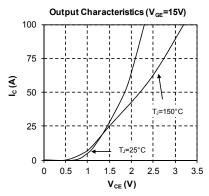
Package outline (dimensions in mm)

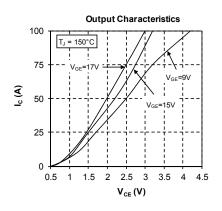


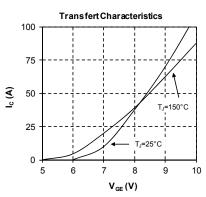
See application note 1906 - Mounting Instructions for SP3F Power Modules on www.microsemi.com

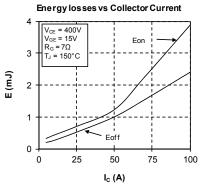


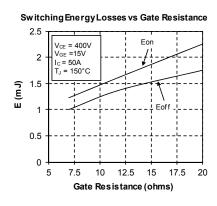
Typical IGBT Performance Curve

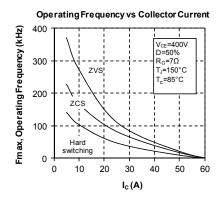


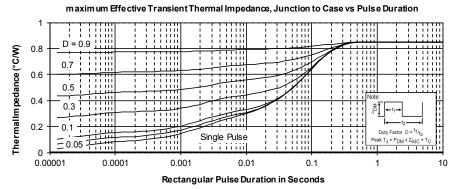






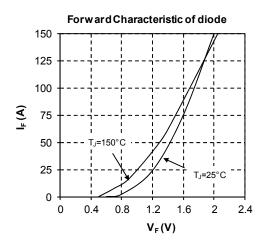




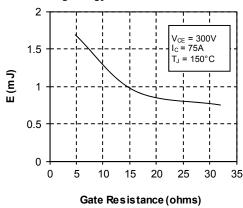




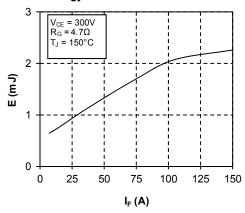
Typical Boost chopper diode Performance Curve

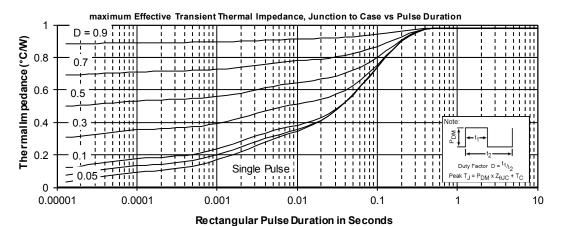


Switching Energy Losses vs Gate Resistance



Energy losses vs Collector Current







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